# **UNIVERSITY OF MUMBAI**



# **Bachelor of Engineering**

Bachelor of Electronics Engineering
Second Year (Semester III and IV), Revised course
(Rev2012) From Academic Year 2013-14

(As per Credit Based Semester and Grading System with effect from the academic year 2012–2013)

#### Preamble:

To meet the challenges of ensuring excellence in engineering education, the issue of quality needs to be addressed, debated and taken forward in a systematic manner. Accreditation is the principal means of quality assurance in higher education. The major emphasis of accreditation process is to measure the outcomes of the program that is being accredited. In line with this Faculty of Technology of University of Mumbai has taken a lead in incorporating philosophy of outcome based education in the process of curriculum development.

Faculty of Technology, University of Mumbai, in one of its meeting unanimously resolved that, each Board of Studies shall prepare some Program Educational Objectives (PEO's) and give freedom to affiliated Institutes to add few (PEO's) and course objectives and course outcomes to be clearly defined for each course, so that all faculty members in affiliated institutes understand the depth and approach of course to be taught, which will enhance learner's learning process. It was also resolved that, maximum senior faculty from colleges and experts from industry to be involved while revising the curriculum. I am happy to state that, each Board of studies has adhered to the resolutions passed by Faculty of Technology, and developed curriculum accordingly. In addition to outcome based education, semester based credit and grading system is also introduced to ensure quality of engineering education.

Semester based Credit and Grading System enables a much-required shift in focus from teacher centric to learner-centric education since the workload estimated is based on the investment of time in learning and not in teaching. It also focuses on continuous evaluation which will enhance the quality of education. University of Mumbai has taken a lead in implementing the system through its affiliated Institutes and Faculty of Technology has devised a transparent credit assignment policy and adopted ten points scale to grade learner's performance. Credit and grading based system was implemented for First Year of Engineering from the academic year 2012-2013. Subsequently this system will be carried forward for Second Year Engineering in the academic year 2013-2014, for Third Year and Final Year Engineering in the academic years 2014-2015 and 2015-2016 respectively.

Dr. S. K. Ukarande Dean, Faculty of Technology, Member - Management Council, Senate, Academic Council University of Mumbai, Mumbai

#### **Preamble:**

The engineering education in India in general is expanding in manifolds. Now, the challenge is to ensure its quality to the stakeholders along with the expansion. To meet this challenge, the issue of quality needs to be addressed, debated and taken forward in a systematic manner. Accreditation is the principal means of quality assurance in higher education and reflects the fact that in achieving recognition, the institution or program of study is committed and open to external review to meet certain minimum specified standards. The major emphasis of this accreditation process is to measure the outcomes of the program that is being accredited. Program outcomes are essentially a range of skills and knowledge that a student will have at the time of graduation from the program. An engineering program must ensure that its graduates understand the basic concepts of science and mathematics, have gone through one engineering field in dept of appreciate and use its methodologies of analyses and design, and have acquired skills for lifelong learning.

An engineering program must therefore have a mission statement which is in conformity with program objectives and program outcomes that are expected of the educational process. The outcomes of a program must be measureable and must be assessed regularly through proper feedback for improvement of the programme. There must be a quality assurance process in place within the Institute to make use of the feedback for improvement of the programme. The curriculum must be constantly refined and updated to ensure that the defined objectives and outcomes are achieved. Students must be encouraged to comment on the objectives and outcomes and the role played by the individual courses in achieving them. In line with this Faculty of Technology of University of Mumbai has taken a lead in incorporating philosophy of outcome based education in the process of curriculum development.

I, as Chairman, Board of Studies in Electronics Engineering University of Mumbai, is happy to state here that, Program Educational Objectives were finalized in a meeting where more than 20 members from different Institutes have attended, who were either Heads or their representatives of Electronics Engineering Department. The Program Educational Objectives finalized for undergraduate program in Electronics Engineering are listed below;

- To provide students with a strong foundation in the mathematical, scientific and engineering fundamentals necessary to formulate, solve and analyze engineering problems at hand and to prepare them for graduate studies.
- To prepare students to demonstrate an ability to identify, formulate and solve electronics engineering problems.
- To prepare students to demonstrate ability to design electrical and electronics systems and conduct experiments, analyze and interpret data.
- To prepare students to demonstrate for successful career in industry to meet needs of Indian and multi-national companies.
- To develop the ability among students to synthesize data and technical concepts from applications to product design.
- To provide opportunity to students to work as part of teams on multidisciplinary projects.
- To promote awareness among students for the life-long learning and to introduce them to professional ethics and codes of professional practice.

In addition to above more program educational objectives of their own may be added by affiliated Institutes and Heads of Departments.

In addition to Program Educational Objectives, for each course of undergraduate program, objectives and expected outcomes from learner's point of view are also included in the curriculum to support the philosophy of outcome based education. I believe strongly that small step taken in right direction will definitely help in providing quality education to the stake holders.

Dr. Dileep G. Borse Chairman, Board of Studies in Electronics Engineering University of Mumbai

# SE Electronics Engineering Semester III Credit and Evaluation Scheme Semester III

Sub	Subject Name	Teachi	ng Scheme	(Hrs.)		Credits Assi	gned	
Code		Theory	Practical	Tutorial	Theory	Practical/TW	Tutorial	Total
EXS301	*Applied Mathematics III	04		01	04		01	05
EXC302	Electronic Devices	04			04			04
EXC303	Digital Circuits and Design	04			04			04
EXC304	Circuit Theory	04			04			04
EXC305	Electronic Instruments and Measurements	04			04			04
EXL301	Electronic Devices Laboratory	1	02			01		01
EXL302	Digital Circuits and Design Laboratory		02			01		01
EXL303	Circuit Theory and Measurements Laboratory		02			01		01
EXL304	*Object Oriented Programming Methodology Laboratory		02+02**			02		02
Total		20	10	01	20	04	01	26

<sup>\*</sup>Common subject with EXTC

<sup>\*\* 2</sup> Hours be converted to theory for entire class and 2 hour for hands on practice.

Subject	Subject Name			Exa	mination	Scheme	2		
Code	_		The	ory Marks		Term	Practical	Oral	Total
		Inte	rnal As	ssessment	End	Work	and		
		Test 1	Test	Ave. of	Sem.		Oral		
			2	Test 1 and	Exam				
				Test 2					
EXS301	*Applied Mathematics III	20	20	20	80	***25			125
EXC302	Electronic Devices	20	20	20	80				100
EXC303	Digital Circuits and	20	20	20	80				100
	Design								
EXC304	Circuit Theory	20	20	20	80				100
EXC305	Electronic Instruments and	20	20	20	80				100
	Measurements								
EXL301	Electronic Devices					25	50		75
	Laboratory								
EXL302	Digital Circuits and					25	50		75
	Design Laboratory								
EXL303	Circuit Theory and					25			25
	Measurements Laboratory								
EXL304	*Object Oriented					25	50		75
	Programming Laboratory								
				100	400	125	150		775

<sup>\*</sup>Common subject with EXTC

<sup>\*\*\*</sup> Tutorial work will be assessed as term work

# SE Electronics Engineering Semester III Syllabus of Theory Subjects

Subject Code	Subject Name	To	eaching Sch	eme		Credits Assigned			
		Theory	Practical	Tutorial	Theory	Practical	Tutorial- work	Total	
EXS 301	Applied Mathematics III	04		01	04	-	01	05	

Subject	Subject Name		Examination Scheme								
Code			T	heory Marks		Tutorial	Practical	Oral	Total		
		<b>Internal assessment</b>			End	as Term					
		Test	Test	Ave. Of	Sem.	Work					
		1	2	Test 1 and	Exam						
				Test 2							
EXS	Applied	20	20	20	80	25			125		
301	Mathematics III										

# **Course Prerequisite:**

FE C 101: Applied Mathematics I FE C 201: Applied Mathematics II

#### **Course Objective:**

- To provide students with a sound foundation in Mathematics and prepare them for graduate studies in Electronics Engineering
- To make students to understand mathematics' fundamentals necessary to formulate, solve and analyze engineering problems.

# **Expected Outcome:**

- Students will demonstrate basic knowledge of Laplace Transform. Fourier Series, Bessel Functions, Vector Algebra and Complex Variable.
- Students will demonstrate an ability to identify formulate and solve electronics Engineering problems using Applied Mathematics.
- Students will show the understanding of impact of engineering mathematics in the engineering
- Students will become capable and eligible to participate and succeed in competitive exams like GATE, GRE.

Module No.	Unit No.	Topics	Hrs.
1.0	110.	Laplace Transform	12
	1.1	<b>Laplace transform (LT) of standard functions:</b> Definition. Unilateral and bilateral Laplace transform, LT of $sin(at)$ , $cos(at)$ , $e^{at}$ , $t^n$ , $sinh(at)$ , $cosh(at)$ , $erf(t)$ , Heavi-side unit step, direct-delta function, LT of periodic function	
	1.2	<b>Properties of Laplace transform:</b> linearity, first shifting theorem, second shifting theorem, multiplication by $t^n$ , division by $t$ , Laplace transform derivatives and integrals, change of scale, convolution theorem, initial and final value theorem, Parsevel's identity	
	1.3	Inverse Laplace Transform: Partial fraction method, long division method, residue method, theorem of LT to find inverse	
	1.4	Applications of Laplace transform : Solution of ordinary differential equations	
2.0		Fourier Series	10
	2.1	<b>Introduction:</b> Definition, Dirichlet's conditions, Euler's formulae	
	2.2	<b>Fourier series of functions:</b> exponential, trigonometric functions, even and odd functions, half range sine and cosine series	
	2.3	Complex form of Fourier series, Fourier integral representation	
3.0		Bessel functions	08
	3.1	<b>Solution of Bessel differential equation:</b> series method, recurrence relation, properties of Bessel Function of order +1/2 and -1/2	
	3.2	Generating function, orthogonality property	
	3.3	Bessel Fourier series of a functions	
4.0		Vector Algebra	12
	4.1	<b>Scalar and vector product</b> : Scalar and vector product of three and four vectors and their properties	
	4.2	<b>Vector differentiation :</b> Gradient of scalar point function, divergence and curl of vector pint function	
	4.3	<b>Properties:</b> Solenoidal and Irrotational vector fields, conservative vector field	
	4.4	<b>Vector integral:</b> Line integral, Green's theorem in a plane, Gauss Divergence theorem, Stokes' theorem	
5.0		Complex Variable	10
	5.1	<b>Analytic function:</b> Necessary and sufficient conditions, Cauchy Reiman. equations in polar form	
	5.2	Harmonic function, orthogonal trajectories	
	5.3	<b>Mapping:</b> Conformal mapping, bilinear transformations, cross ratio, fixed points, bilinear transformation of straight lines and circles.	
		Total	52

#### **Recommended Books**

- 1. P. N. Wartikar and J. N. Wartikar, "A Text Book of Applied Mathematic", Vol. I & II, Vidyarthi Griha Prakashan, Pune
- 2. A Datta, "Mathematical Methods in Science and Engineerin", 2012
- 3. Dr. B.S. Grewal, "Higher Engineering Mathematics", Khanna Publication
- 4. B. S. Tyagi, "Functions of a Complex Variable," Kedarnath Ram Nath Publication
- 5. B V Ramana, "Higher Engineering Mathematics", Tata McGraw-Hill Publication
- 6. Wylie and Barret, "Advanced Engineering Mathematics", McGraw-Hill 6th Edition
- 7. Erwin Kreysizg, "Advanced Engineering Mathematics", John Wiley & Sons, Inc
- 8. Murry R. Spieget, "Vector Analysis", Schaun's Out Line Series, McGraw Hill Publication

#### **Internal Assessment (IA):**

Two tests must be conducted which should cover 80% of syllabus. The average marks of two tests will be considered as final IA marks

#### **End Semester Examination:**

- 1. Question paper will comprise of 6 questions, each carrying 20 marks.
- 2. The students need to solve total 4 questions.
- 3: Question No.1 will be compulsory and based on entire syllabus.
- 4: Remaining questions (Q.2 to Q.6) will be set on all the modules.
- 5: Weight age of marks will be as per Blueprint.

#### Term Work:

At least **08** assignments covering entire syllabus must be given during the **Class Wise Tutorial.** The assignments should be students' centric and an attempt should be made to make assignments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every assignment graded from time to time.** The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

Subject Code	Subject Name	Teaching Scheme				Credits Assigned			
		Theory	Practical	Tut.	Theory	TW/Pract.	Tut.	Total	
EXC302	Electronic Devices	04		-	04		-	04	

	Subject Name	Examination Scheme							
Sub.		Theory Marks				TW	Pract and	Oral	Total
Code		Internal	Internal Assessment End				Oral.		
EXC302	Electronic Devices	Test 1	Test 2	Average of Test1 & Test2	Semester Exam				
		20	20	20	80				100

# Prerequisite: FEC105 Basic Electrical & Electronics Engineering Course Objectives:

- 1. To deliver the knowledge about physics of basic semiconductor devices
- 2. To enhance comprehension capabilities of students through understanding of electronic devices
- 3. To introduce and motivate students to the use of advanced microelectronic devices
- 4. To create foundation for forthcoming circuit design courses

# **Course Outcome:**

- 1. Ability to understand semiconductor devices through energy band diagrams
- 2. Ability to analyze characteristics of semiconductor junctions
- 3. Ability to differentiate between bipolar and unipolar conduction
- 4. Ability to understand physics of optical devices
- 5. Ability to understand working principle of power devices
- 6. Knowledge about advanced semiconductor devices used in research
- 7. Ability to appreciate the role of semiconductor devices in various applications

Module No.	Topics	Hrs.							
1.0	Junction Analysis	14							
1.1	<b>PN junction Diode:</b> Basic Structure, Energy Band Diagrams, Zero Applied Bias, Forward								
	Applied Bias, Reverse Applied Bias, PN Junction current, Small signal model of PN								
	junction, Generation and recombination of currents, junction breakdown.								
	er Diode: Breakdown mechanisms, Characteristics, Effect of Temperature,								
	Application as voltage regulator and backward diode								
	Varactor diode: Working and characteristics								
	Tunnel diode: V-I Characteristics and working								
	<b>TED</b> ( <b>Transferred Electron Device</b> ): Basic concept, Negative differential resistance, V-I								
	Characteristics and working of <b>Gunn Diode</b>								
	IMPATT: Static and Dynamic Characteristics								

1.2	Metal semiconductor and semiconductor Heterojunctions:	
	Schottkey barrier diode: Qualitative characteristics, Ideal junction properties, Nonideal	
	effects on barrier height and V-I characteristics	
	Metal-semiconductor ohmic contacts: Ideal Non rectifying barriers, Tunneling Barrier,	
	Specific contact resistance  Heterojunctions: Heterojunction materials, Energy Band Diagrams, Two dimensional	
	electron gas.	
2	Bipolar Devices	08
2.1	BJT: The bipolar transistor action, minority carrier distribution, low-frequency common-	00
2.1	base current gain, non-ideal effects, Ebers-Moll Model, Gummel-Poon Model, Hybrid-Pi	
	Model, Frequency Limitations	
2.2	HBT (Heterojunction bipolar transistor): Current gain in HBT, Basic n-p-n HBT structure	
	with band diagram	
3.0	Field Effect Devices	16
3.1	JFET: Construction, operation and device characteristics. V-I relationship and	
	transconductance. Small signal equivalent model, frequency limitation factors and cutoff	
	frequency	
3.2	MOSFET:Two terminal MOS structure, MOSFET construction, Band diagrams under	
	equilibrium and external bias, Threshold Voltage, V-I and CV characteristics, Channel	
	length modulation, Short Channel effects, MOSFET Model	
3.3	<b>MESFET:</b> Device structure, principle of operation, V-I characteristics, High frequency	
	performance	
	MODFET (i.e HEMT): Fundamentals, V-I Characteristics, Cutoff Frequency	
4.0	Optical Devices	06
4.1	Optical absorption: Photon absorption coefficient, EHP generation rate	
	<b>Solar Cells:</b> The pn junction, heterojunction and amorphous silicon solar cells	
4.2	Photodetectors: Photoconductor, photodiode, PIN photodiode, APD (avalanche	
	photodiode), phototransistor	
	Optocouplers: Operation, construction, specifications and applications	
7.0	n n	00
5.0	Power Devices PNPN Diode: Basic structure and characteristics	08
5.1	SCR: Basic structure and characteristics SCR: Basic structure, characteristics, Two transistor analogy.	
	<b>DIAC and TRIAC:</b> Basic Structure and characteristics	
	DATO and TRATE. Dasic Structure and characteristics	
5.2	GTO: Basic structure and characteristics	
	PUT: Operation and characteristics	
	<b>UJT:</b> Operation, characteristics, parameters and UJT as a relaxation oscillator	
	<b>IGBT:</b> Device structure, equivalent circuit and characteristics	
	-	
	Total	52

#### **Recommended Books:**

- 1. Donald A. Neamen, "Semiconductor Physics and Devices" Tata MCGraw Hill, Third Edition
- 2. S. M. Sze, "Semiconductor Devices: Physics and Technology", Wiley, Second Edition
- 3. Sung-Mo Kang, Yusuf Leblebici, "CMOS Digital Integrated Circuits", Tata McGraw Hill, Third Edition
- 4. David Bell, "Electronic Devices and Circuits", Oxford, Fifth Edition.
- 5. S Slivahanan and N. Suresh Kumar, "Electronic Devices and Circuits", McGraw Hill, Third Edition
- 6. Gordon W. Roberts and Adel S. Sedra, "Spice", Oxford, Second Edition

#### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

#### **End Semester Examination:**

- 1. Question paper will comprise of 6 questions, each carrying 20 marks.
- 2. The students need to solve total 4 questions.
- 3: Question No.1 will be compulsory and based on entire syllabus.
- 4: Remaining question (Q.2 to Q.6) will be set from all the modules.
- 5: Weightage of marks will be as per Blueprint.

Subject Code	Subject Name	Teacl	ning Scheme		Credits Assigned			
		Theory	Pract.	Tut.	Theory	TW/Pract.	Tut.	Total
EXC303	Digital Circuits and Design	04		-	04		-	04

	Subject Name Examination Scheme								
C1-		Marks	KS			Pract.	Oral	Total	
Sub. Code		Internal	Internal Assessment End						
EXC303	Digital Circuits and Design	Test 1	Test 2	Average of Test1 & Test2	Semester Exam				
		20	20	20	80		-		100

# Prerequisite: FEC105 Basic Electrical & Electronics Engineering

# **Course Objectives:**

- 1. To deliver the knowledge, motivate and train students in logic design
- 2. To introduce the students to various logic gates, SOP, POS and their minimization techniques.
- 3. To explain and describe various logic families and to provide information on different IC's.
- 4. To teach the working of combinational circuits and their applications.
- 5. To make students aware of characteristics of various types of SSI, LSI and MSI devices and their use in various applications.
- 6. To teach students to analyze, understand and design sequential circuits.
- 7. To describe State Machines and explain their design using state diagrams.
- 8. To explain various types of programmable devices
- 9. To train students in writing program with hardware description languages.
- 10. To prepare students for understanding courses like microprocessors, microcontrollers, VLSI design, embedded systems and digital communications

#### **Course Outcome:**

- 1. Ability to develop a logic and apply it to solve real life problems
- 2. Ability to understand current applications, trends and new directions in logic design
- 3. Ability to reduce SOP and POS equations.
- 4. Ability to understand differences between logic families TTL and CMOS
- 5. Ability to understand various SSI, LSI and MSI devices
- 6. Ability to use SSI, LSI and MSI devices in various applications
- 7. Ability to analyze, design and implement combinational circuits
- 8. Ability to analyze, design and implement sequential circuits
- 9. Ability to solve state machines
- 10. Ability to design state machines using state diagrams, State Reduction techniques and State machine synthesis using transition lists
- 11. Ability to understand the concept of simulation, synthesis and implementation
- 12. Ability to use hardware description languages for logic circuit design.
- 13. Ability to understand programmable logic devices
- 14. Ability to program CPLD and FPGA

Module No.	Topics	Hrs.
1.0	Fundamentals of Digital Design	14
1.1	Logic Gates: Review of basic gates, Universal gates, Sum of products and products	
	of sum, minimization with Karnaugh Map (upto four variables) and realization.	
1.2	Logic Families: Types of logic families (TTL and CMOS), characteristic parameters	
	(propagation delays, power dissipation, Noise Margin, Fan-out and Fan-in), transfer	
	characteristics of TTL NAND, Interfacing CMOS to TTL and TTL to CMOS.	
1.3	Combinational Circuits using basic gates as well as MSI devices: Half adder, Full	
	adder, Half Subtractor, Full Subtractor, multiplexer, demultiplexer, decoder,	
	Comparator (Multiplexer and demultiplexer gate level upto 4:1).	
	MSI devices IC7483, IC74151, IC74138, IC7485.	
2.0	Elements of Sequential Logic Design :	10
2.1	Sequential Logic: Latches and Flip-Flops (Conversions, timing considerations and	
	metastability are <b>not</b> expected)	
2.2	Counters: Asynchronous, Synchronous Counters, Up Down Counters, Mod	
	Counters, Ring Counters Shift Registers, Universal Shift Register	
3.0	Sequential Logic Design:	10
3.1	Mealy and Moore Machines, Clocked synchronous state machine analysis, State	
	reduction techniques and state assignment, Clocked synchronous state machine	
	design. (Complex word problems like traffic light controller etc. are not expected)	
3.2	MSI counters (7490, 74163, 74169) and applications, MSI Shift registers (74194) and	
	their applications	
4.0	Programmable Logic Devices:	07
4.1	Concepts of PAL and PLA. Simple logic implementation using PAL and PLA.	
	Introduction to CPLD and FPGA architectures.	
5.0	Simulation:	07
5.1	Functional Simulation, Timing simulation, Logic Synthesis, RTL	
5.2	Introduction to VHDL, Framework of VHDL Program.	
6.0	Testability:	06
6.1	Fault Models, Stuck at faults, Bridging faults, Controllability and Observability	
6.2	Path sensitization, ATPG, Design for Testability, Boundary Scan Logic, JTAG and	
	Built in self test.	
	Total	52

# **Recommended Books**

- 1. William I. Fletcher, 'An Engineering Approach to Digital Design', PHI.
- 2. B. Holdsworth and R. C. Woods, 'Digital Logic Design', Newnes, 4<sup>th</sup> Edition
- 3. Morris Mano, Digital Design, Pearson Education, Asia 2002.
- 4. John F. Wakerley, Digital Design Principles And Practices, third Edition Updated, Pearson Education, Singapore, 2002
- 5. Anil K. Maini, Digital Electronics, Principles, Devices and Applications, Wiley
- 6. Stephen Brown and Zvonko Vranesic, Fundamentals of digital logic design with VHDL, McGraw Hill, 2<sup>nd</sup> Edition.

# **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

# **End Semester Examination:**

- 1. Question paper will comprise of 6 questions, each carrying 20 marks.
- 2. The students need to solve total 4 questions.
- 3: Question No.1 will be compulsory and based on entire syllabus.
- 4: Remaining question (Q.2 to Q.6) will be set from all the modules.
- 5: Weightage of marks will be as per Blueprint.

Subject Code	Subject Name	To	eaching Sch	eme	Credits Assigned					
		Theory	Practical	Tutorial	Theory	TW	Tutorial	Total		
EXC304	Circuit Theory	04			04			04		

Subject	Subject		Examination Scheme									
Code	Name		<b>T</b> ]	heory Marks	5	Term	Practical	Oral	Total			
		Into	ernal as	sessment	End Sem.	Work						
		Test	Test	Ave. of 2	Exam							
		1	2	Tests								
EXC304	Circuit	20	20	20	80				100			
	Theory											

# **Course Pre-requisite:**

FEC 105: Basic Electrical and Electronics Engineering

Partial fraction expansion, matrices, determinants calculus and differential equations,

# **Course Objectives:**

- 1. To analyze the circuits in time and frequency domain
- 2. To study network functions, inter relationship among various circuit parameters, solve more complex network using these parameters.
- 3. To analyze and synthesize circuits and to become familiar with the propagation of signals/wave through transmission lines.

#### **Course Outcome:**

- 1. Through test and laboratory exercises, students will be able to apply their knowledge in solving complex circuits.
- 2. Students will be able to evaluate the time and frequency response which is useful in understanding behavior of electronic circuits and control system.
- 3. Student will be able to understand how the power or information in terms of electromagnetic energy is transmitted through the transmission lines and importance of impedance matching.

# SE ELECTRONICS ENGINEERING R-2012

Module No.	Unit No.	Topics	Hrs
1.0		Analysis of Electrical Circuits	09
	1.1	<b>Analysis of DC circuits:</b> Analysis of circuits with and without controlled sources using generalized loop, node matrix, Superposition, Thevenin, Norton, Millman theorems	
	1.2	<b>Analysis of coupled circuits:</b> Self and mutual inductances, coefficient of coupling, Dot convention, equivalent circuit, solution using loop analysis	
	1.3	Series and parallel resonance circuits: Selectivity, bandwidth, quality factor	
2.0		Time and Frequency Domain Analysis	12
	2.1	Time domain analysis of R-L and R-C circuits: Forced and natural response, time constant, initial and final values  Solution using first order equation for standard input signals: Transient and steady state time response, solution using universal formula	
	2.2	Time domain analysis of R-L-C circuits: Forced and natural response, effect of damping Solution using second order equation for standard input signals: Transient and steady state time response	
	2.3	<b>Frequency domain analysis of RLC circuits:</b> S-domain representation, applications of Laplace Transform in solving electrical networks, driving point and transfer function, Poles and Zeros, calculation of residues by analytical and graphical method, frequency response	
3.0		Synthesis of RLC Circuits	06
	3.1	<b>Positive real functions:</b> Concept of positive real function, testing for Hurwitz polynomials, testing for necessary and sufficient conditions for positive real functions	
	3.2	<b>Synthesis of RC, RL, LC circuits:</b> Concepts of synthesis of RC, RL, LC driving point functions (numerical problems not expected on 3.2)	
4.0		Two Port Networks	08
	4.1	<b>Parameters:</b> Open Circuit, Short Circuit, Transmission and Hybrid parameters, relationships among parameters, reciprocity and symmetry conditions	
	4.2	<b>Series/parallel connection:</b> T and Pi representations, interconnection of Two-Port networks,	
5.0		Flirters and attenuators	08
	5.1	<b>Basic filter circuits:</b> Low pass, high pass, band pass and band stop filters, transfer function, frequency response, cutoff frequency, bandwidth, quality factor, attenuation constant, phase shift, characteristic impedance	
	5.2	Concept of design and analysis of filters: Constant K, M derived and composite filters (numerical problems not expected on 5.2)	
	5.3	<b>Attenuators:</b> Basic concepts, classification, attenuation in dB, K factor (impedance factor) and design concepts (numerical problems not expected on 5.3)	
6.0		Transmission Lines	09
	6.1	<b>Power frequency lines:</b> Representation, losses and efficiency in power lines, effect of length, calculation of inductance and capacitance (numerical problems not expected)	
	6.2	Radio frequency lines: Representation, propagation constant, attenuation constant, phase constant, group velocity, input impedance, characteristic impedance, reflection coefficient, standing wave ratio, VSWR, ISWR, S-parameters	
	6.3	Smith Chart: Impedance locus diagram, impedance matching	
		Total	52

#### **Recommended Books:**

- 1. Franklin F Kuo, "Network Analysis and Synthesis", Wiley Toppan,
- 2. M E Van Valkenburg, "Network Analysis", Prentice-Hall of India Pvt Ltd, New Delhi
- 3. K V V Murty and M S Kamth, "Basic Circuit Analysis", Jaico Publishing house, London
- 4. A. Chakrabarti, "Circuit Theory", Dhanpat Rai and Co., New Delhi
- 5. Reinhold Ludwig and Pavel Bretchko, "RF Circuit Design", Pearson Education, Asia
- 6. Joseph J. Carr, "Secrets of RF Circuit Design", Tata McGraw-Hill, New Delhi

# **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

#### **End Semester Examination:**

- 1. Question paper will comprise of 6 questions, each carrying 20 marks.
- 2. The students need to solve total 4 questions.
- 3: Question No.1 will be compulsory and based on entire syllabus.
- 4: Remaining question (Q.2 to Q.6) will be set from all the modules.
- 5: Weightage of marks will be as per Blueprint.

Subject Code	Subject Name	Te	eaching Sche	me	Credits Assigned					
		Theory	Practical	Tutorial	Theory	TW/ Practical	Tutorial	Total		
EXC 305	Electronic Instruments and Measurements	04			04			04		

Subject	Subject Name				Examinati	on Scheme					
Code			Th	eory Marks	S	Term	Practical	Oral	Total		
		Inte	rnal ass	sessment	End Sem.	Work					
		Test	Test	Ave. Of	Exam						
		1	2	Test 1							
				and Test							
				2							
EXC305	Electronic	20	20	20	80	-	-		100		
	Instruments and										
	Measurements										

# **Prerequisite Topics:**

System of units, Measuring Instrument.

# **Course Objective:**

Objectives of this course are:

- 1. In depth knowledge of measurement methods and instruments of electrical quantities.
- 2. Understanding design aspects and performance criterion for measuring instruments.
- 3. Implementation of the different signal generators and its analysis techniques.
- 4. To understand the working principle of the transducers.
- 5. To aware the students about the advances in Instrumentation.

# **Course Outcomes:**

The outcomes of this course are:

- 1. An ability to apply knowledge of electronic instrumentation for measurement of electrical quantities.
- 2. Ability to apply the principles and practices for instrument design and development to real world problems.
- 3. Ability to select and use latest hardware for measurements and instrumentation.
- 4. An ability to design and conduct experiments for measurement and ability to analyze and interprets data.

Module No	Topics	Hrs.
1.	Principles of Measurement	06
	<b>1.1 Introduction to Basic Instruments:</b> Components of Generalized measurement system, applications of instrument systems, static and dynamic characteristics of instruments, Concepts of Accuracy, Precision, Linearity, Sensitivity, Resolution, Hysteresis, Calibration etc.	
	<b>1.2 Errors in Measurement:</b> Errors in Measurement, Classification of Errors, Remedies to Eliminate/Reduce Errors.	
2	Test and Measuring Instruments	10
	<b>2.1 Analog Multi-meters:</b> Multi-range, Multi-parameter Measurement, Electronics Voltmeter using Transistors, FETs and Opamps. Specifications of a multi-meter.	
	<b>2.2 RLC and Q-meter:</b> Measurement of Low, Medium and High Resistance using Wheatstone bridge, Kelvin's Double Bridge and Mega ohm Bridge; Measurement of Inductance using Maxwell Bridge and Hey Bridge; Measurement of Capacitance using Schering Bridge; Operating Principle and Applications of Q-Meter.	
	<b>2.3 Digital Multi-meters:</b> DMM; Automation, Auto Ranging and Auto Zero Adjustments in Digital Instruments.	
3	Oscilloscopes	10
	<b>3.1 Cathode Ray Oscilloscope:</b> Block Diagram based Study of CRO, Specifications, Controls, Sweep Modes, Role of Delay Line, Single- and Dual-Beam Dual-Trace CROs, Chop and Alternate Modes.	
	<ul> <li>3.2 Measurement using Oscilloscope: Measurement of Voltage, Frequency, Rise Time, Fall Time and Phase Difference. Lissajous Figures in Detection of Frequency and Phase.</li> <li>3.3 Digital Storage Oscilloscope (DSO): Features like Roll, Refresh, Storage Mode and Sampling Rate; Applications of DSO.</li> </ul>	
4	Transducers for Displacement and Temperature Measurement	08
	<b>4.1 Basics of Transducers/Sensors :</b> Characteristics of Transducers; Requirement of Transducers; Classification of transducers; Selection Criteria of Transducers.	
	<b>4.2 Displacement:</b> Potentiometers; Linear Variable Differential Transformer, Resistance Strain Gauges, Capacitance Sensors.	
	<b>4.3 Temperature:</b> RTD, Thermisters, Thermocouples- Their Ranges, and Applications.	
5	Transducers for Pressure, Level and Flow Measurement  5.1 Pressure: Pressure gauges; Elastic Pressure Transducers; Dead Weight Tester; Vacuum Pressure Measurement- McLeod Gauge and Pirani Gauge.	10
	<b>5.2 Level:</b> Side glass tube method; Float type methods; Capacitance type method; Ultrasonic type transducer.	
	<b>5.3 Flow:</b> Restriction type Flow meters-Orifice and Venturi; Rotameter; Magnetic Flow meter; Turbine Flow meter.	
6	Data Acquisition and advances in Instrumentation Systems	08
	6.1 Monitoring Instruments: Indicators, Alarm, Recorders.	
	<b>6.2 Data Acquisition and Converters</b> : Data logger; Data acquisition system (DAS)-Single channel, Multichannel.	
	<b>6.3 PC based Instrumentation</b> : PC based Instrumentation System; Introduction to Programmable Logic Controller.	
	Total	52

#### **Rcommended Books:**

- 1. H. Oliver and J. M. Cage, Electronic Measurement and Instrumentation, McGraw Hill, 3rd edition.
- 2. W. Cooper, A. Helfric, Electronic Instrumentation and Measurement Techniques, PHI, 4th edition.
- **3.** C. S. Rangan, G.R. Sarma, V.S.V. Mani, Instrumentation Devices and Systems, Tata McGraw Hill, 9<sup>th</sup> edition.
- **4.** A. K. Sawhney, Electrical & Electronic Instruments & Measurement, Dhanpat Rai and Sons, Eleventh ed., 2000.
- **5.** Dally, William F. Riley and Kenneth G, Instrumentation for Engineering Measurements, James John Wiley and Sons. Inc., 2nd Edition 1993.
- **6.** A.J. Bowens, Digital Instrumentation, McGraw-Hill, latest addition.
- 7. J.J.Carr, Elements of Electronic Instrumentation and Control, Prentice Hall, 3rd edition.

#### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

#### **End Semester Examination:**

- 1. Question paper will comprise of 6 questions, each carrying 20 marks.
- 2. The students need to solve total 4 questions.
- 3: Question No.1 will be compulsory and based on entire syllabus.
- 4: Remaining question (Q.2 to Q.6) will be set from all the modules.
- 5: Weightage of marks will be as per Blueprint.

# SE Electronics Engineering Semester III Syllabus of Laboratory

Subject Code	Subject Name	Teach	ning Scheme	;	Credits Assigned				
		Theory	Practical	Theory	TW/Pract.	Tut.	Total		
EXL301	Electronic Devices Laboratory		02	-		01	-	01	

	Subject Name	Examin	ation Scl	heme					
Sub.		Theory	Marks			TW	Pract and	Oral	Total
Code		Internal	Assessn	nent		Oral.			
EXL301	Electronic Devices	Test 1	Test 2	Average of Test1 & Test2	Semester Exam				
	Laboratory					25	50		75

Syllabus: Same as that of Subject EXC 302 Electronic Devices

# Term Work:

At least 10 experiments covering entire syllabus of EXC 302 (Electronic Devices) should be set to have well predefined inference and conclusion. Computation/simulation based experiments are encouraged. Therefore at least 5 simulation experiments to be carried out (out of total 10 Expts.). The experiments should be students' centric and attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the overall performance of the student with every experiment graded from time to time. The grades should be converted into marks as per the Credit and Grading System manual and should be added and averaged. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work. Practical and Oral exam will be based on the entire syllabus.

# **Guidelines for Simulation Experiments:**

- 1. One SPICE simulations and implementation for junction analysis
- 2. One SPICE simulation and implementation for BJT characteristics
- 3. One SPICE simulation and implementation for JFET characteristics
- 4. One SPICE simulation and implementation for Optical devices
- 5. One SPICE simulation and implementation for power devices
- 6. One SPICE simulation for MOSFET characteristics

Subject	Subject	Te	aching Sch	eme		Credits Assigned				
Code	Name									
		Theory	Practical	Tutorial	Theory	TW	Tutorial	Total		
EXL 302	Digital		02			01		01		
	Circuits and									
	Design									
	Laboratory									

Subject	Subject			]	Scheme				
Code	Name			Theory Marks		Term	Practical	Oral	Total
		Int	ernal a	ssessment	End Sem.	Work	and		
		Test	Test	Ave. Of Test	Exam		Oral		
		1	2	1 and Test 2					
EXL 302	Digital					25	50	-	75
	Circuits and								
	Design								
	Laboratory								

Syllabus: Same as EXC 303 (Digital Circuits and Design)

#### Term Work:

At least 10 experiments covering entire syllabus of EXC 303 (Digital Circuits and Design) should be set to have well predefined inference and conclusion. Computation/simulation based experiments are encouraged. Therefore, 5 simulation experiments be carried out (out of total 10 Expts.). The experiments should be students' centric and attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the overall performance of the student with every experiment graded from time to time. The grades should be converted into marks as per the Credit and Grading System manual and should be added and averaged. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work. Practical and Oral exam will be based on the entire syllabus.

# **Suggested Experiments:**

- 1. SOP and POS Minimization (different problem statement for each student)
- 2. Characteristics of TTL and MOS logic family
- 3. Implementation of combinational circuits using MSI devices. (at least two)
- 4. Implementation of counters with flip-flops (at least one synchronous and one asynchronous)
- 5. Implementation of sequential circuits using MSI devices. (at least two)
- 6. Implementation of FSM (different problem statement for each student)
- 7. VHDL based simulations (Instructor should teach syntax and give different program to each student for simulation. Minimum Four programs covering behavioral, structural and dataflow modeling)
- 8. Verilog/VHDL based simulations (Instructor should teach syntax and give different program to each student for simulation. Minimum Four programs covering behavioral, structural, dataflow and switch level modeling)
- 9. Synthesis, downloading and Verification on CPLD and FPGA (for both VHDL and Verilog programs)
- 10. Troubleshooting of given fault (teacher should generate set of faults in different circuits and ask students to troubleshoot)

Subject Code	Subject Name	Т	Ceaching School	eme	Credits Assigned				
		Theory	Practical	Tutorial	Theory	TW	Tutorial	Total	
EXL 303	Circuit Theory and Measurements Laboratory		02			01		01	

Subject	Subject Name		Examination Scheme							
Code			,	Theory Marks		Term	Practical	Oral	Total	
		Int	ernal a	ssessment	End Sem.	Work	and			
		Test	Test	Ave. Of Test	Exam		Oral			
		1	2	1 and Test 2						
EXL	Circuit Theory and					25			25	
303	Measurements									
	Laboratory									

Syllabus: EXC 304 (Circuit Theory) and

**EXC 305 (Electronic Instruments and Measurements)** 

05 Experiments Each

# Term Work:

At least 05 experiments on of EXC 304 (Circuit Theory) and 05 experiments on EXC 305 (Electronic Instruments and Measurements) based on the entire syllabus should be set to have well predefined inference and conclusion. Computation/simulation based experiments are also encouraged. The experiments should be students' centric and attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every experiment graded from time to time.** The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work. Practical and Oral exam will be based on the entire syllabus.

Subject Code	Subject Name	Teaching Scheme			Credits Assigned				
		Theory	Practical	Tutorial	Theory	Term Work and Pract.	Tutorial	Total	
EXL 304	*Object Oriented Programming Methodology Laboratory		02+02**			02		02	

Subject	Subject Name	Examination Scheme							
Code		Theory Marks				Term	Practical	Oral	Total
		Internal assessment			End Sem.	Work	and		
		Test	Test	Ave. Of Test	Exam		Oral		
		1	2	1 and Test 2					
EXL 304	*Object					25	50	-	75
	Oriented								
	Programming								
	Methodology								
	Laboratory								

<sup>\*\* 02</sup> Hours be converted to theory hours for entire class theory discussion

Pre-requites: Course in Structured Programming Approach/ Any Programming Language

# **Course Objectives:**

- 1. To understand the concept of Object Oriented Programming
- 2. To help student to understand how to use a programming language such as JAVA to resolve problems.
- 3. To impart problems understanding, analyzing skills in order to formulate Algorithms.
- 4. To provide knowledge about JAVA fundamentals: data types, variables, keywords and control structures.
- 5. To understand methods, arrays, inheritance, Interface, package and multithreading.
- 6. To understand the concept of Applet.

#### **Course Outcomes:**

- 1. Students will be able to code a program using JAVA constructs.
- 2. Given an algorithm a student will be able to formulate a program that correctly implements the algorithm.
- 3. Students will be able to generate different patterns and flows using control structures.
- 4. Students will be able to make use of recursion in their programs.
- 5. Students will be able to use thread methods, thread exceptions and thread priority.
- 6. Students will implement method overloading in their code.
- 7. Students will be able to demonstrate reusability with the help of inheritance.
- 8. Students will be able to make more efficient programs.

Module	Unit	Торіс	Hrs.			
No.	No.					
1		Fundamental concepts of object oriented programming	4			
	1.1	Overview of Programming				
	1.2	Introduction to the principles of object-oriented programming: Classes,				
		Objects, Messages, Abstraction, Encapsulation, Inheritance,				
		Polymorphism, exception handling, and object-oriented containers				
	1.3	Differences and Similarity between C++ and JAVA				
2		Fundamental of Java Programming				
	2.1	Features of Java				
	2.2	JDK Environment & tools				
	2.3	Structure of java program				
	2.4	Keywords, Data types, Variables, Operators, Expressions				
	2.5	Decision Making, Looping, Type Casting				
	2.6	Input output using scanner class				
3		Classes and Objects	6			
	3.1	Creating Classes and objects				
	3.2	Memory allocation for objects				
	3.3	Passing parameters to Methods				
	3.4	Returning parameters				
	3.5	Method overloading				
	3.6	Constructor and finalize()				
	<b>3.7</b>	Arrays: Creating an array				
	3.8	Types of Array: One Dimensional arrays, Two Dimensional array				
4		Inheritance, Interface and Package	6			
	4.1	Types of Inheritance : Single ,Multilevel, Hierarchical				
	4.2	Method Overriding, Super keyword, Final Keyword, Abstract Class	]			
	4.3	Interface	]			
	4.4	Packages				
5		Multithreading	4			
	5.1	Life cycle of thread				
	5.2	Methods				
	5.3	Priority in multithreading				
6		Applet	2			
	6.1	Applet Life cycle				
	6.2	Creating applet	]			
	6.3	Applet tag				
		Total	26			

# Term Work:

At least 10 experiments covering entire syllabus should be set to have well predefined inference and conclusion. The experiments should be students' centric and attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every experiment graded from time to time.** The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work. Practical and Oral exam will be based on the entire syllabus.